Power MOSFET

60 V, 37 A, 11.5 m Ω

Features

- Low R_{DS(on)}
- Low Capacitance
- Optimized Gate Charge
- These Devices are Pb-Free and are RoHS Compliant

MAXIMUM RATINGS (T_J = 25°C unless otherwise stated)

Parameter			Symbol	Value	Unit
Drain-to-Source Voltage			V_{DSS}	60	V
Gate-to-Source Voltage			V _{GS}	±20	V
Continuous Drain		T _A = 25°C	I _D	11	Α
Current R _{θJA} (Note 1)		T _A = 100°C		7	
Power Dissipation R _{0JA}		T _A = 25°C	P_{D}	2.7	W
(Note 1)	Steady	T _A = 100°C		1.1	
Continuous Drain	State	T _C = 25°C	I _D	37	Α
Current R _{θJC} (Note 1)		T _C = 100°C		24	
Power Dissipation		T _C = 25°C	P _D	33	W
R _{θJC} (Note 1)		T _C = 100°C		13	
Pulsed Drain Current	t _p =	10 μs	I _{DM}	149	Α
Operating Junction and Storage Temperature			T _J , T _{stg}	-55 to +150	°C
Source Current (Body Diode)			Is	37	Α
Single Pulse Drain-to-Source Avalanche Energy		E _{AS}	48	mJ	
			I _{AS}	31	Α
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			TL	260	°C

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case - Steady State (Note 1)	$R_{ hetaJC}$	3.8	°C/W
Junction-to-Ambient - Steady State (Note 1)	$R_{ hetaJA}$	46.7	

Surface-mounted on FR4 board using 1 in sq pad size (Cu area = 1.127 in sq [2 oz] including traces.

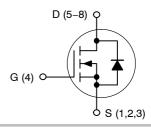


ON Semiconductor®

http://onsemi.com

V _{(BR)DSS}	V _{(BR)DSS} R _{DS(on)} MAX	
60 V	11.5 mΩ @ 10 V	37 A
00 V	15 mΩ @ 4.5 V	37 A

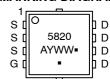
N-Channel MOSFET





CASE 511AB

MARKING DIAGRAM



5820 = Specific Device Code A = Assembly Location

Y = Year WW = Work Week

= Pb-Free Package

(Note: Microdot may be in either location)

ORDERING INFORMATION

Device	Package	Shipping [†]
NTTFS5820NLTAG	WDFN8 (Pb-Free)	1500 / Tape & Reel
NTTFS5820NLTWG	WDFN8 (Pb-Free)	5000 / Tape & Reel

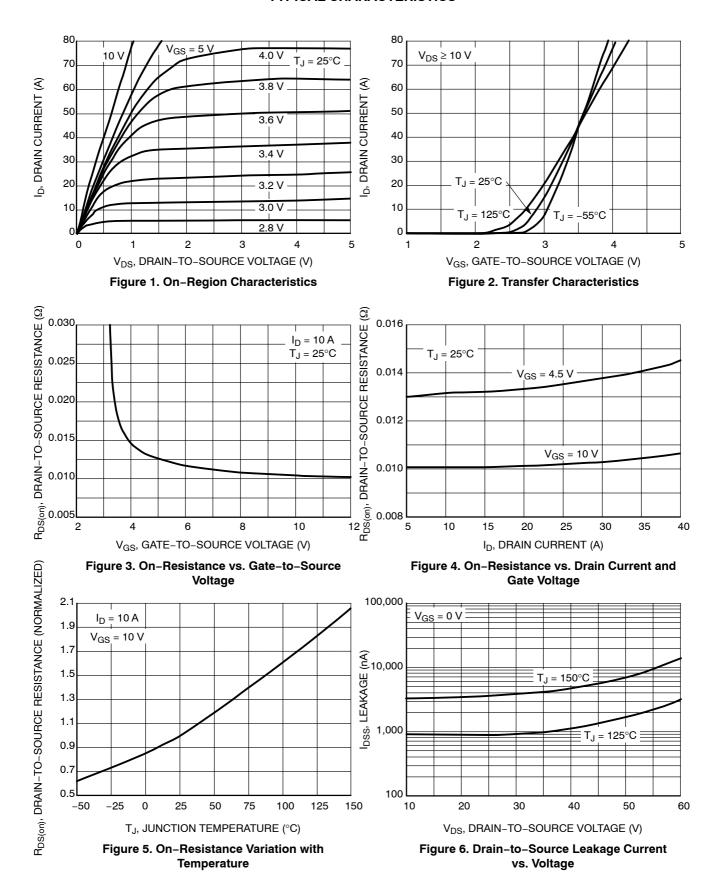
†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

ELECTRICAL CHARACTERISTICS ($T_J = 25^{\circ}C$ unless otherwise specified)

Parameter	Symbol	Test Condi	tion	Min	Тур	Max	Unit
OFF CHARACTERISTICS	•				-	-	-
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		60			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} /T _J				57		mV/°C
Zero Gate Voltage Drain Current	I _{DSS}	V _G = 0 V.	T _J = 25°C			1.0	μΑ
		$V_{GS} = 0 V$, $V_{DS} = 60 V$	T _J = 125°C			10	
Gate-to-Source Leakage Current	I _{GSS}	V _{DS} = 0 V, V _{GS}	= ±20 V			±100	nA
ON CHARACTERISTICS (Note 2)	•		•		•		•
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}, I_D =$	= 250 μA	1.5		2.3	V
Negative Threshold Temperature Coefficient	V _{GS(TH)} /T _J				6.2		mV/°C
Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = 10 V	I _D = 8.7 A		10.1	11.5	mΩ
		V _{GS} = 4.5 V	I _D = 7.3 A		13.0	15	7
Forward Transconductance	g _{FS}	V _{DS} = 5 V, I _D = 10 A			24.6		S
CHARGES, CAPACITANCES AND GA	ATE RESISTAN	ICE			-	2	Į.
Input Capacitance	C _{iss}				1462		pF
Output Capacitance	C _{oss}	V _{GS} = 0 V, f = 1.0 MH	lz, V _{DS} = 25 V		150		1
Reverse Transfer Capacitance	C _{rss}				96		
Total Gate Charge	Q _{G(TOT)}	V _{GS} = 10 V, V _{DS} = 4	8 V, I _D = 10 A		28		nC
		V _{GS} = 4.5 V, V _{DS} = 4	8 V, I _D = 10 A		15		
Threshold Gate Charge	Q _{G(TH)}				1		nC
Gate-to-Source Charge	Q _{GS}				4		
Gate-to-Drain Charge	Q_{GD}	$V_{GS} = 4.5 \text{ V}, V_{DS} = 4$	8 V, I _D = 10 A		8		
Plateau Voltage	V_{GP}				3		V
Gate Resistance	R_{G}				0.62		Ω
SWITCHING CHARACTERISTICS (No	ote 3)		<u>'</u>				ı
Turn-On Delay Time	t _{d(on)}				10		ns
Rise Time	t _r	V _{GS} = 4.5 V, V _D	e = 48 V.		28		
Turn-Off Delay Time	t _{d(off)}	$I_D = 10 \text{ A}, R_G = 2.5 \Omega$			19		
Fall Time	t _f				22		
DRAIN-SOURCE DIODE CHARACTE	RISTICS		L		•		•
Forward Diode Voltage	V _{SD}	V _{GS} = 0 V, I _S = 10 A	T _J = 25°C		0.79	1.2	V
			T _J = 125°C		0.65		
Reverse Recovery Time	t _{RR}	$V_{GS} = 0 \text{ V}, d_{IS}/d_t = 100 \text{ A/}\mu\text{s},$ $I_S = 10 \text{ A}$			19		ns
Charge Time	t _a				13		
Discharge Time	t _b				6		
Reverse Recovery Charge	Q _{RR}				15		nC

^{2.} Pulse Test: pulse width $\leq 300~\mu s$, duty cycle $\leq 2\%$. 3. Switching characteristics are independent of operating junction temperatures.

TYPICAL CHARACTERISTICS



TYPICAL CHARACTERISTICS

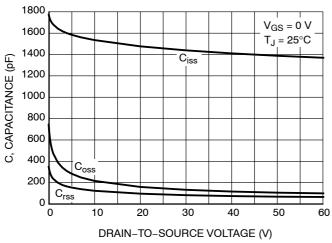


Figure 7. Capacitance Variation

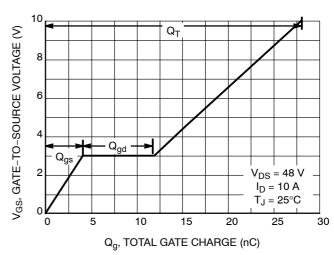


Figure 8. Gate-to-Source Voltage vs. Total Charge

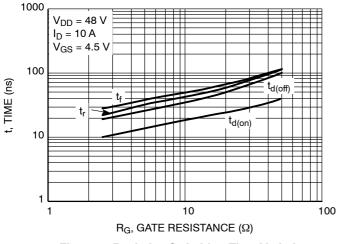


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

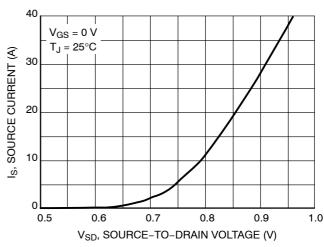


Figure 10. Diode Forward Voltage vs. Current

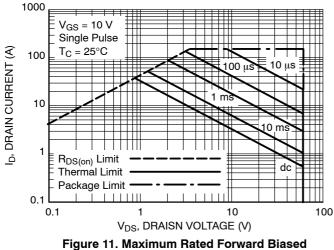


Figure 11. Maximum Rated Forward Biased
Safe Operating Area

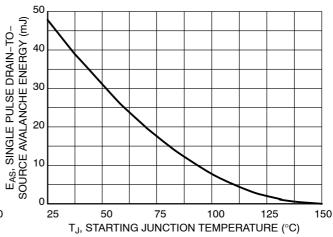


Figure 12. Maximum Avalanche Energy vs. Starting Junction Temperature

TYPICAL CHARACTERISTICS

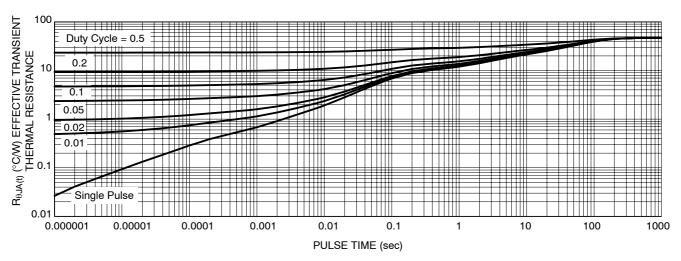
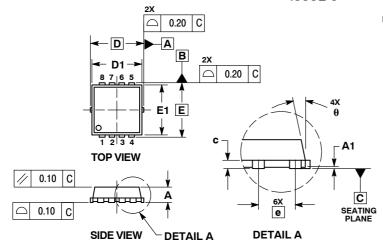


Figure 13. Thermal Response

PACKAGE DIMENSIONS

WDFN8 3.3x3.3, 0.65P

CASE 511AB ISSUE C

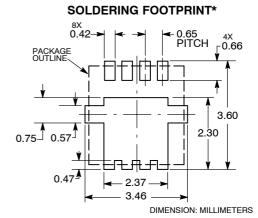


NOTES:

- 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M. 1994.
- 2. CONTROLLING DIMENSION: MILLIMETERS.
- DIMENSION D1 AND E1 DO NOT INCLUDE MOLD FLASH PROTRUSIONS OR GATE BURRS.

	MILLIMETERS			INCHES		
DIM	MIN	NOM	MAX	MIN	NOM	MAX
Α	0.70	0.75	0.80	0.028	0.030	0.031
A1	0.00		0.05	0.000		0.002
b	0.23	0.30	0.40	0.009	0.012	0.016
С	0.15	0.20	0.25	0.006	0.008	0.010
D	3.30 BSC			C	.130 BSC	;
D1	2.95	3.05	3.15	0.116	0.120	0.124
D2	1.98	2.11	2.24	0.078	0.083	0.088
E		3.30 BSC		0.130 BSC		
E1	2.95	3.05	3.15	0.116	0.120	0.124
E2	1.47	1.60	1.73	0.058	0.063	0.068
E3	0.23	0.30	0.40	0.009	0.012	0.016
е	0.65 BSC		0.026 BSC			
G	0.30	0.41	0.51	0.012	0.016	0.020
K	0.64			0.025		
L	0.30	0.43	0.56	0.012	0.017	0.022
L1	0.06	0.13	0.20	0.002	0.005	0.008
М	1.40	1.50	1.60	0.055	0.059	0.063
θ	0°		12°	0°		12°

8X 0.10 C A B 0.05 C 4X L 4X L



*For additional information on our Pb —Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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